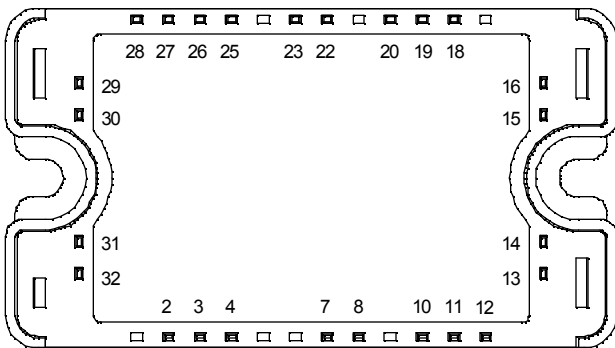
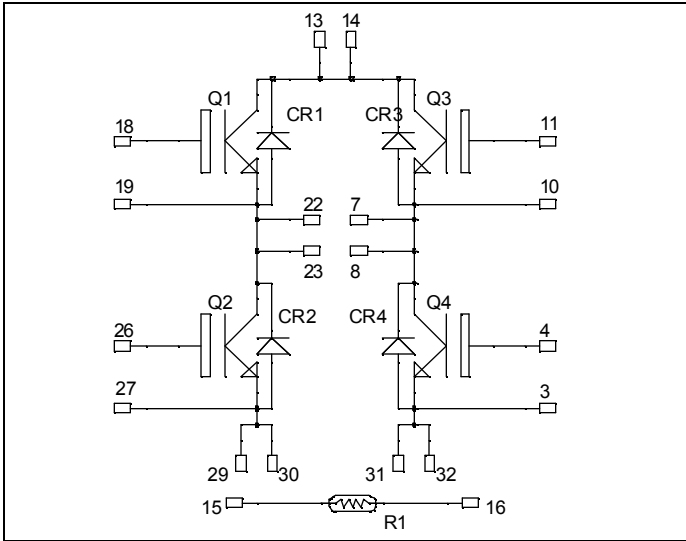


## Full - Bridge NPT IGBT Power Module

**$V_{CES} = 1200V$**   
 **$I_C = 15A @ T_c = 80^\circ C$**



All multiple inputs and outputs must be shorted together  
 Example: 13/14 ; 29/30 ; 22/23 ...

### Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

### Features

- Non Punch Through (NPT) Fast IGBT®
  - Low voltage drop
  - Low tail current
  - Switching frequency up to 50 kHz
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - Avalanche energy rated
  - RBSOA and SCSOA rated
  - Symmetrical design
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration
- Internal thermistor for temperature monitoring

### Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- Easy paralleling due to positive  $T_C$  of  $V_{CESat}$
- Each leg can be easily paralleled to achieve a phase leg of twice the current capability
- RoHS compliant

### Absolute maximum ratings

Symbol	Parameter	Max ratings	Unit
$V_{CES}$	Collector - Emitter Breakdown Voltage	1200	V
$I_C$	Continuous Collector Current	$T_C = 25^\circ C$	25
		$T_C = 80^\circ C$	15
$I_{CM}$	Pulsed Collector Current	$T_C = 25^\circ C$	60
$V_{GE}$	Gate - Emitter Voltage	$\pm 20$	V
$P_D$	Maximum Power Dissipation	$T_C = 25^\circ C$	140
RBSOA	Reverse Bias Safe Operating Area	$T_j = 125^\circ C$	30A@1150V

**CAUTION:** These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on [www.microsemi.com](http://www.microsemi.com)

All ratings @  $T_j = 25^\circ\text{C}$  unless otherwise specified

**Electrical Characteristics**

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit	
$I_{CES}$	Zero Gate Voltage Collector Current	$V_{GE} = 0\text{V}$ $V_{CE} = 1200\text{V}$	$T_j = 25^\circ\text{C}$			250	$\mu\text{A}$
			$T_j = 125^\circ\text{C}$			500	
$V_{CE(sat)}$	Collector Emitter Saturation Voltage	$V_{GE} = 15\text{V}$ $I_C = 15\text{A}$	$T_j = 25^\circ\text{C}$	2.5	3.2	3.7	V
			$T_j = 125^\circ\text{C}$		4.0		
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 1\text{mA}$	4		6	V	
$I_{GES}$	Gate – Emitter Leakage Current	$V_{GE} = 20\text{V}, V_{CE} = 0\text{V}$			400	nA	

**Dynamic Characteristics**

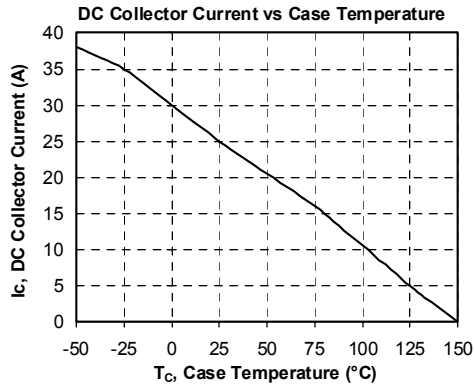
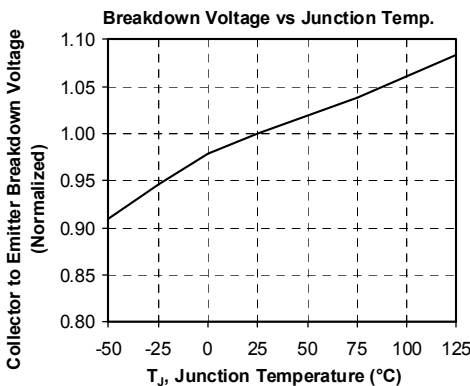
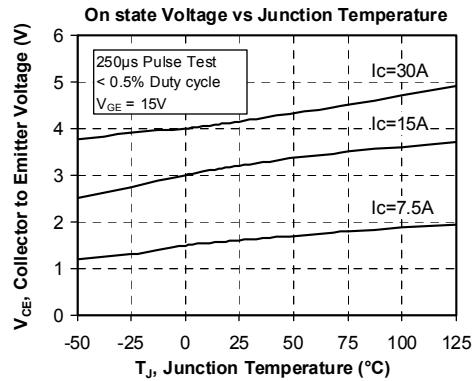
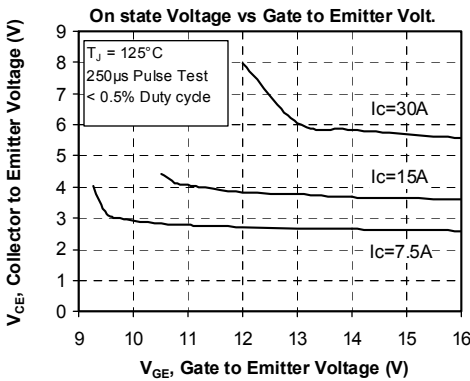
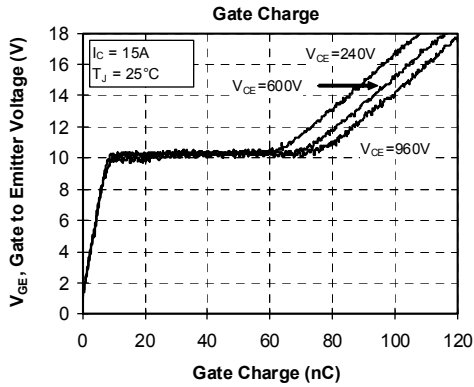
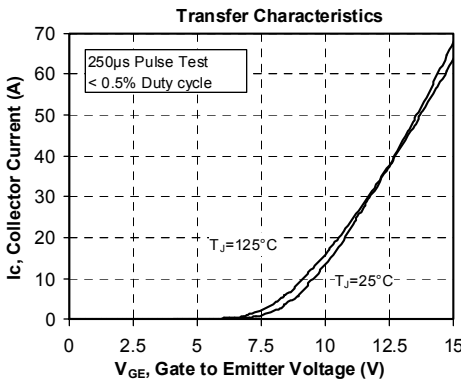
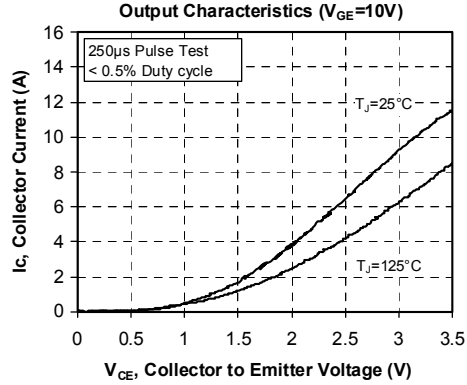
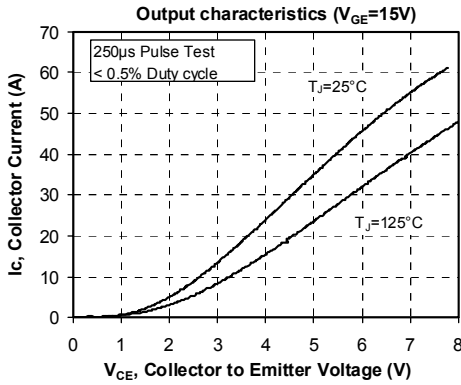
Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$C_{ies}$	Input Capacitance	$V_{GE} = 0\text{V}$ $V_{CE} = 25\text{V}$ $f = 1\text{MHz}$		1000		$\mu\text{F}$
$C_{oes}$	Output Capacitance			150		
$C_{res}$	Reverse Transfer Capacitance			70		
$Q_g$	Total gate Charge	$V_{GE} = 15\text{V}$ $V_{Bus} = 300\text{V}$ $I_C = 15\text{A}$		99		nC
$Q_{ge}$	Gate – Emitter Charge			10		
$Q_{gc}$	Gate – Collector Charge			70		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching ( $25^\circ\text{C}$ ) $V_{GE} = 15\text{V}$ $V_{Bus} = 400\text{V}$ $I_C = 15\text{A}$ $R_G = 33\Omega$		60		ns
$T_r$	Rise Time			50		
$T_{d(off)}$	Turn-off Delay Time			315		
$T_f$	Fall Time			30		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching ( $125^\circ\text{C}$ ) $V_{GE} = 15\text{V}$ $V_{Bus} = 400\text{V}$ $I_C = 15\text{A}$ $R_G = 33\Omega$		60		ns
$T_r$	Rise Time			50		
$T_{d(off)}$	Turn-off Delay Time			356		
$T_f$	Fall Time			40		
$E_{on}$	Turn-on Switching Energy	$V_{GE} = 15\text{V}$ $V_{Bus} = 400\text{V}$ $I_C = 15\text{A}$ $R_G = 33\Omega$	$T_j = 125^\circ\text{C}$	2		mJ
$E_{off}$	Turn-off Switching Energy		$T_j = 125^\circ\text{C}$	1		

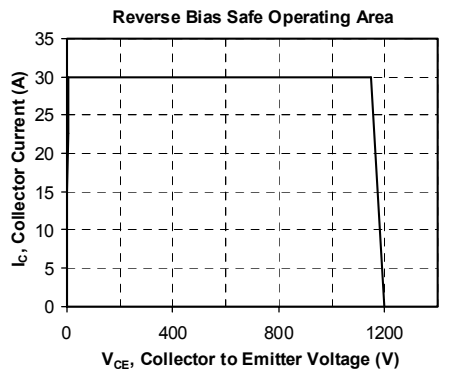
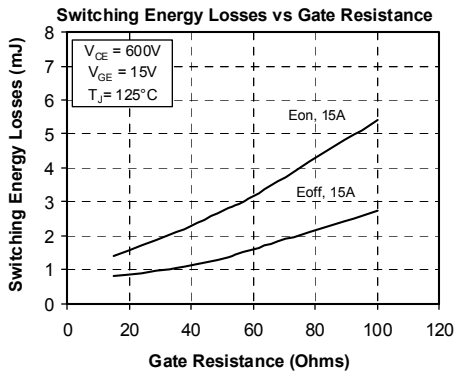
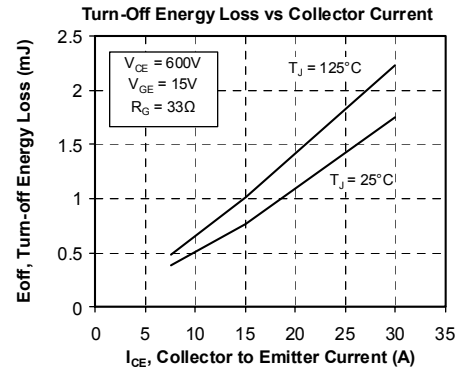
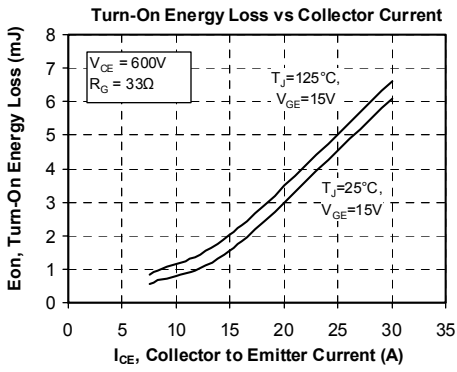
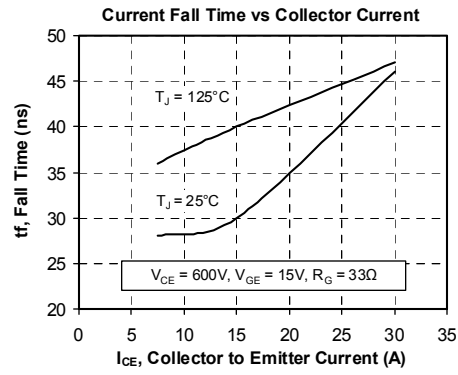
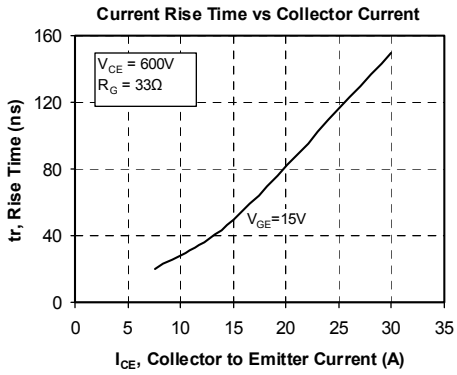
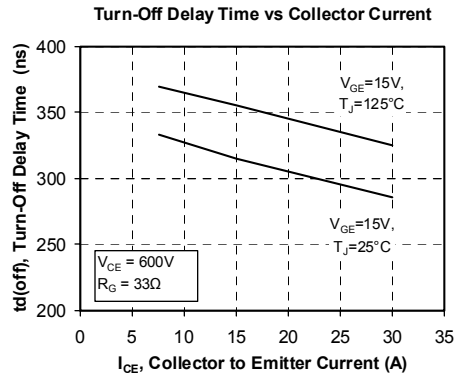
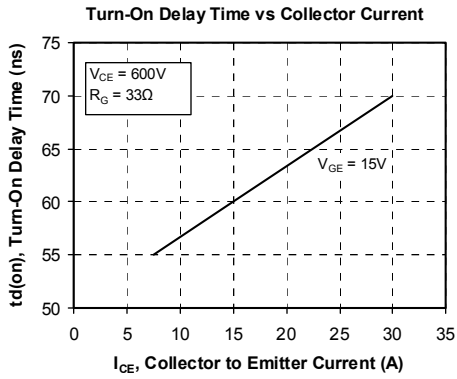
**Reverse diode ratings and characteristics**

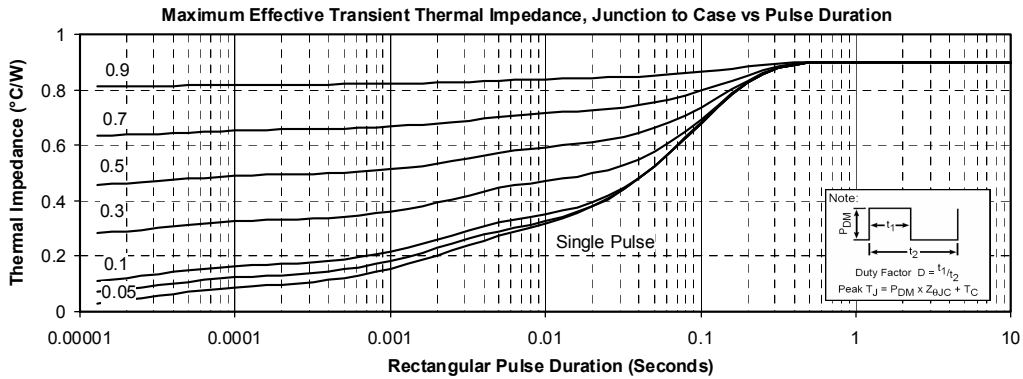
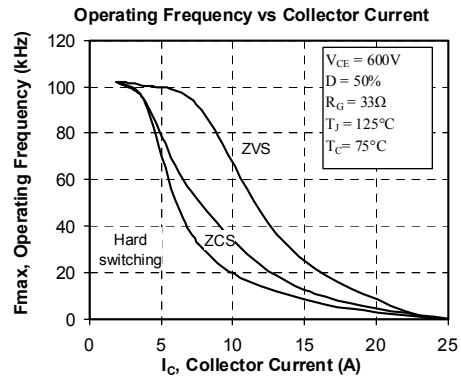
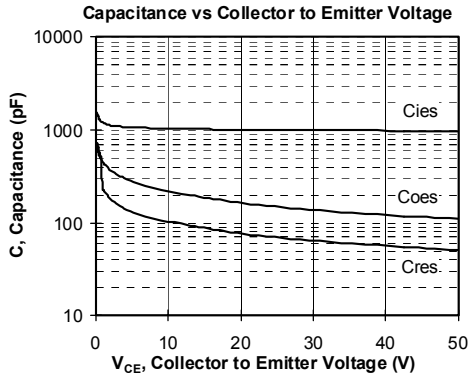
Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit	
$V_{RRM}$	Maximum Peak Repetitive Reverse Voltage		1200			V	
$I_{RM}$	Maximum Reverse Leakage Current	$V_R = 1200\text{V}$	$T_j = 25^\circ\text{C}$			250	$\mu\text{A}$
			$T_j = 125^\circ\text{C}$			500	
$I_F$	DC Forward Current			15		A	
$V_F$	Diode Forward Voltage	$I_F = 15\text{A}$ $V_{GE} = 0\text{V}$	$T_j = 25^\circ\text{C}$		2.1		V
			$T_j = 125^\circ\text{C}$		1.9		
$t_{rr}$	Reverse Recovery Time	$I_F = 15\text{A}$ $V_R = 600\text{V}$ $di/dt = 1000\text{A}/\mu\text{s}$	$T_j = 25^\circ\text{C}$		95		ns
			$T_j = 125^\circ\text{C}$		190		
$Q_{rr}$	Reverse Recovery Charge		$T_j = 25^\circ\text{C}$		1.5		$\mu\text{C}$
			$T_j = 125^\circ\text{C}$		3.1		
$E_r$	Reverse Recovery Energy		$T_j = 25^\circ\text{C}$		0.5		mJ
			$T_j = 125^\circ\text{C}$		1.2		



## Typical Performance Curve







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